Special Issue

Applications of Advanced Sensors on Applied System Innovation of IoT (Internet of Things)

Message from the Guest Editors

Internet of Things (IoT) devices offer huge potential for electronic component manufacturers, but their value clearly goes beyond this. Most of the added value in IoT solutions will come from the processing of the generated data. In fact, the ratio between electronic components and data processing can reach 1:50 in certain long-term cases. This is easily understandable, since the main purpose of the IoT is to make sensing ubiquitous at a very low cost, resulting in extremely strong price pressure on electronic component manufacturers. Potential topics include, but are not limited to:

- Flectrochemical sensors/Biosensors on IoT
- 2. Electrical- and thermal-based sensors on IoT
- 3. Mass-sensitive and fiber-optic sensors on IoT
- 4. Optoelectronic and Photonic Sensors on IoT
- Gas sensors on IoT
- Sensor devices and sensor arrays/Nano sensors on IoT
- 7. Advanced sensors analysis and design for IoT
- 8. Applied System Innovation of advanced sensors on IoT

Guest Editors

Prof. Dr. Cheng-Fu Yang

Department of Chemical and Materials Engineering, National University of Kaohsiung, Kaohsiung, Taiwan

Dr. Stephen D. Prior

Aeronautics, Astronautics and Computational Engineering, University of Southampton, Southampton SO16 7QF, UK

Deadline for manuscript submissions

closed (30 June 2019)



Applied System Innovation

an Open Access Journal Published by MDPI

Impact Factor 3.7 CiteScore 9.9



mdpi.com/si/12165

Applied System Innovation Editorial Office MDPI, Grosspeteranlage 5 4052 Basel, Switzerland Tel: +41 61 683 77 34 asi@mdpi.com

mdpi.com/journal/ asi





Applied System Innovation

an Open Access Journal Published by MDPI

Impact Factor 3.7 CiteScore 9.9



About the Journal

Message from the Editor-in-Chief

Editor-in-Chief

Prof. Dr. Christos Douligeris

Department of Informatics, University of Piraeus, 18534 Piraeus, Greece

Author Benefits

Open Access:

free for readers, with article processing charges (APC) paid by authors or their institutions.

High Visibility:

indexed within Scopus, ESCI (Web of Science), Inspec, Ei Compendex and other databases.

Journal Rank:

JCR - Q2 (Engineering, Electrical and Electronic) / CiteScore - Q1 (Applied Mathematics)

